

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HAN ET AL.	
		Examiner Nathan W. Ha	Art Unit 2814	Page 1 of 1

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	B	US-2005/0082561 A1	04-2005	Suehiro et al.	257/099
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NON-PATENT DOCUMENTS

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